

Search Notes



Application No.

10/047,577

Examiner

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Applicant(s)

DAVIES ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
705	1	6/26/04	sn
	7		
	8		
	9		
	11		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Classified search 705 / 7,8,9	6/26/04	sn
US		
1) PG Pub 2) Patent		
FOREIGN		
1) EPO 2) JPO 3) Derwent		
NPL		